Applications of Machine Learning in Real World

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Message from the Guest Editors

We are pleased to invite you to contribute with your valuable research work to this Special Issue, "Applications of Machine Learning in Real World", which aims to further advance the knowledge of machine learning engineers and researchers by providing a critical update on recent applications of machine learning to solve real-world problems.

In this Special Issue, original research articles and reviews are welcome. Research areas may include (but are not limited to) the following:

- Applications of Machine Learning in Different Domains (Natural Language Processing, Healthcare, Visual Analysis, Telecommunication, Power, etc.);
- Real-time Forecasting using Machine Learning;
- Machine Learning Algorithms for Embedded Systems.

We look forward to receiving your contributions.

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Special Issue

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Message from the Editor-in-Chief

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